

<b>Notice of References Cited</b>	Application/Control No. 10/828,272	Applicant(s)/Patent Under Reexamination NAKAJIMA, TOSHIHARU	
	Examiner Tuan C. To	Art Unit 3663	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,351,706	02-2002	Morimoto et al.	701/208
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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